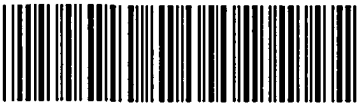


<b>Search Notes</b>  	<b>Application/Control No.</b>  10502211	<b>Applicant(s)/Patent Under Reexamination</b>  SCHOU, FRANK
	<b>Examiner</b>  Kaplan, Hal I	<b>Art Unit</b>  2836

SEARCHED			
Class	Subclass	Date	Examiner
307	56	12/14/2007	HK
307	58	12/14/2007	HK
307	82	12/14/2007	HK
307	23	12/14/2007	HK

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB,USPAT,USOCR,FPRS,EPO,JPO,DERWENT,IBM_TDB) - See Search History Printout	12/14/2007	HK

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
Interference Search History Printout		12/14/2007	HK